# PSMN4R5-40BS



# N-channel 40 V 4.5 m $\Omega$ standard level MOSFET in D2PAK Rev. 1 — 22 March 2012 Product data

Product data sheet

# **Product profile**

# 1.1 General description

Standard level N-channel MOSFET in SOT404 package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

### 1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive sources

# 1.3 Applications

- DC-to-DC convertors
- Load switching

- Motor control
- Server power supplies

#### 1.4 Quick reference data

Table 1. Quick reference data

Parameter	Conditions		Min	Тур	Max	Unit
drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	40	V
drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V}; \text{ see } \frac{\text{Figure 1}}{\text{Model}}$	<u>[1]</u>	-	-	100	Α
total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	148	W
junction temperature			-55	-	175	°C
racteristics						
drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 100 °C; see <u>Figure 13</u> ; see <u>Figure 5</u>		-	5.5	6.5	mΩ
	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 5</u>		-	3.79	4.5	mΩ
haracteristics						
gate-drain charge	$V_{GS}$ = 10 V; $I_D$ = 25 A; $V_{DS}$ = 20 V; see <u>Figure 14</u> ; see <u>Figure 15</u>		-	8.8	-	nC
total gate charge	$V_{GS} = 10 \text{ V}; I_D = 0 \text{ A}; V_{DS} = 0 \text{ V}$		-	35	-	nC
ruggedness						
non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup}$ ≤ 40 V; unclamped; $R_{GS}$ = 50 $\Omega$		-	-	152	mJ
	drain-source voltage drain current total power dissipation junction temperature racteristics drain-source on-state resistance characteristics gate-drain charge total gate charge ruggedness non-repetitive drain-source	drain-source voltage $T_j \ge 25  ^{\circ}\text{C};  T_j \le 175  ^{\circ}\text{C}$ drain current $T_{mb} = 25  ^{\circ}\text{C};  V_{GS} = 10  \text{V};  \text{see } \underline{\text{Figure 1}}$ total power dissipation $T_{mb} = 25  ^{\circ}\text{C};  \text{see } \underline{\text{Figure 2}}$ junction temperature  racteristics  drain-source on-state resistance $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 100  ^{\circ}\text{C};  \text{see } \underline{\text{Figure 13}};  \text{see } \underline{\text{Figure 5}}$ $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 25  ^{\circ}\text{C};  \text{see } \underline{\text{Figure 5}}$ Tharacteristics  gate-drain charge $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 20  \text{V};  \text{see } \underline{\text{Figure 14}};  \text{see } \underline{\text{Figure 15}}$ total gate charge $V_{GS} = 10  \text{V};  I_D = 0  \text{A};  V_{DS} = 0  \text{V}$ ruggedness  non-repetitive drain-source $V_{GS} = 10  \text{V};  T_{j(init)} = 25  ^{\circ}\text{C};  I_D = 100  \text{A};$	drain-source voltage $T_j \ge 25 ^{\circ}\text{C};  T_j \le 175 ^{\circ}\text{C}$ drain current $T_{mb} = 25 ^{\circ}\text{C};  V_{GS} = 10  \text{V};  \text{see } \underline{\text{Figure 1}}$ total power dissipation $T_{mb} = 25 ^{\circ}\text{C};  \text{see } \underline{\text{Figure 2}}$ junction temperature  racteristics  drain-source on-state resistance $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 100 ^{\circ}\text{C};  \text{see } \underline{\text{Figure 13}};  \text{see } \underline{\text{Figure 5}}$ $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 25 ^{\circ}\text{C};  \text{see } \underline{\text{Figure 5}}$ Characteristics  gate-drain charge $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 20  \text{V};  \text{see } \underline{\text{Figure 14}};  \text{see } \underline{\text{Figure 15}}$ total gate charge $V_{GS} = 10  \text{V};  I_D = 0  \text{A};  V_{DS} = 0  \text{V}$ ruggedness  non-repetitive drain-source $V_{GS} = 10  \text{V};  T_{j(init)} = 25 ^{\circ}\text{C};  I_D = 100  \text{A};$	drain-source voltage $T_j \ge 25  ^{\circ}\text{C};  T_j \le 175  ^{\circ}\text{C}$ - drain current $T_{mb} = 25  ^{\circ}\text{C};  V_{GS} = 10  \text{V};  \text{see Figure 1}$ [1] - total power dissipation $T_{mb} = 25  ^{\circ}\text{C};  \text{see Figure 2}$ - junction temperature -55 racteristics drain-source on-state resistance $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 100  ^{\circ}\text{C};  \text{see Figure 13};  \text{see Figure 5}$ $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 25  ^{\circ}\text{C};  \text{see Figure 5}$ - see Figure 5 racteristics gate-drain charge $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 20  \text{V};  \text{see Figure 14};  \text{see Figure 15}$ total gate charge $V_{GS} = 10  \text{V};  I_D = 0  \text{A};  V_{DS} = 0  \text{V}$ - ruggedness non-repetitive drain-source $V_{GS} = 10  \text{V};  T_{j(init)} = 25  ^{\circ}\text{C};  I_D = 100  \text{A};  -$	$ \begin{array}{llllllllllllllllllllllllllllllllllll$	$ \begin{array}{llllllllllllllllllllllllllllllllllll$

<sup>[1]</sup> Continuous current is limited by package



# 2. Pinning information

Table 2. Pinning information

	•			
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain[1]	mb	D
3	S	source		
mb	D	mounting base; connected to drain	1 3	mbb076 S
			SOT404 (D2PAK)	

<sup>[1]</sup> It is not possible to make connection to pin 2

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PSMN4R5-40BS	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

# 4. Marking

Table 4. Marking codes

Type number	Marking code
PSMN4R5-40BS	PSMN4R5-40BS

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		<u> </u>				
Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	40	V
$V_{DGR}$	drain-gate voltage	$T_j \ge 25$ °C; $T_j \le 175$ °C; $R_{GS} = 20$ kΩ		-	40	V
$V_{GS}$	gate-source voltage			-20	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u>	<u>[1]</u>	-	96	Α
		V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>	<u>[1]</u>	-	100	Α
I <sub>DM</sub>	peak drain current	pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 \text{ °C}$ ; see Figure 3		-	545	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	148	W
T <sub>stg</sub>	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T <sub>sld(M)</sub>	peak soldering temperature			-	260	°C
Source-dra	ain diode					
Is	source current	T <sub>mb</sub> = 25 °C	<u>[1]</u>	-	100	Α
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$		-	545	Α
Avalanche	ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup} \le$ 40 V; unclamped; $R_{GS}$ = 50 $\Omega$		-	152	mJ

## [1] Continuous current is limited by package

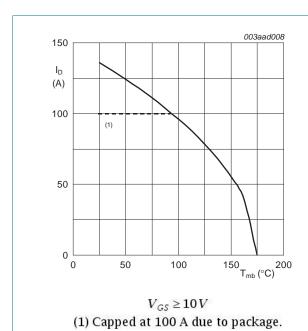
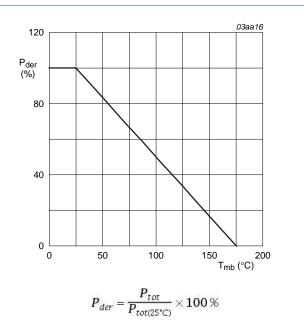


Fig 1. Continuous drain current as a function of mounting base temperature



ig 2. Normalized total power dissipation as a function of mounting base temperature

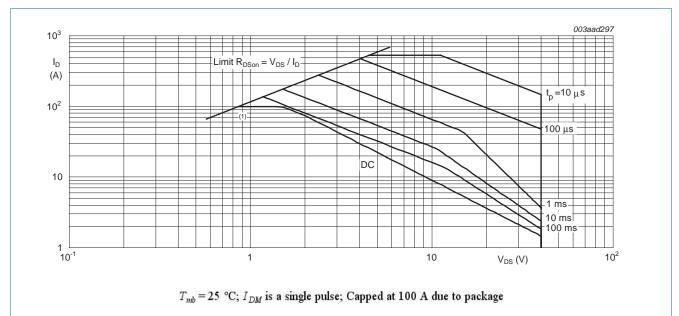


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

# 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	0.65	1	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	Minimum footprint; mounted on a printed circuit board	-	50	-	K/W

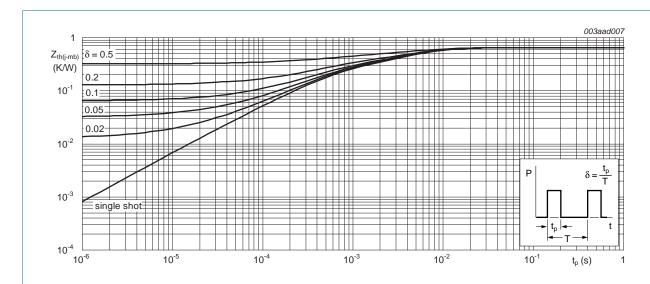


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

# 7. Characteristics

Table 7. Characteristics

Tested to JEDEC standards where applicable.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static char	racteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	36	-	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	40	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see <u>Figure 11</u> ; see <u>Figure 12</u>	-	-	4.6	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 11; see Figure 12	1	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see <u>Figure 11</u> ; see <u>Figure 12</u>	2	3	4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	3	μΑ
		$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$	-	-	60	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = 20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	10	100	nΑ
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
R <sub>DSon</sub> drain-source on-state	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see <u>Figure 13</u> ; see <u>Figure 5</u>	-	7.41	8.7	Ω
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 100 ^{\circ}\text{C};$ see Figure 13; see Figure 5	-	5.5	6.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 5</u>	-	3.79	4.5	mΩ
R <sub>G</sub>	internal gate resistance (AC)	f = 1 MHz	-	0.97	-	Ω
Dynamic c	haracteristics					
Q <sub>G(tot)</sub> total gate charge		$I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V$	-	35	-	nC
		$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$	-	42.3	-	nC
$Q_{GS}$	gate-source charge	see <u>Figure 14</u> ; see <u>Figure 15</u>	-	13.8	-	nC
Q <sub>GS(th)</sub>	pre-threshold gate-source charge		-	7.9	-	nC
Q <sub>GS(th-pl)</sub>	post-threshold gate-source charge		-	5.9	-	nC
$Q_{GD}$	gate-drain charge		-	8.8	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 25 \text{ A}$ ; $V_{DS} = 20 \text{ V}$ ; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	4.8	-	V
C <sub>iss</sub>	input capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	2683	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 16</u>	-	660	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	290	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 20 \text{ V}; R_L = 0.5 \Omega; V_{GS} = 10 \text{ V};$	-	19	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 4.7 \Omega$	-	23	-	ns
$t_{d(off)}$	turn-off delay time		-	30	-	ns
t <sub>f</sub>	fall time		-	9	-	ns

 Table 7.
 Characteristics ...continued

Tested to JEDEC standards where applicable.

Cumbal	Donometer	Canditions	Min	Tim	May	I Imit
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-dra	ain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 17	-	0.75	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$ $V_{GS} = 0 \text{ V}; V_{DS} = 20 \text{ V}$	-	40	-	ns
Q <sub>r</sub>	recovered charge	$I_S = 25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$ $V_{GS} = 0 \text{ V}; V_{DS} = 20 \text{ V}; T_j = 25 \text{ °C}$	-	33	-	nC

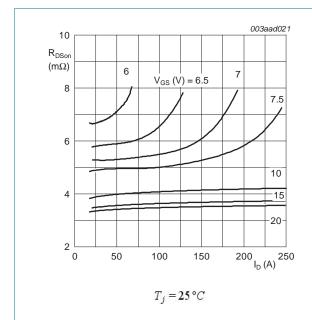


Fig 5. Drain-source on-state resistance as a function of drain current; typical values

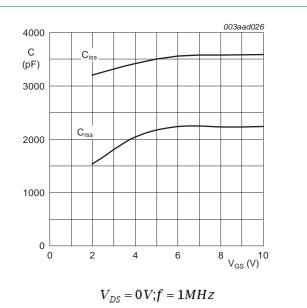


Fig 6. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

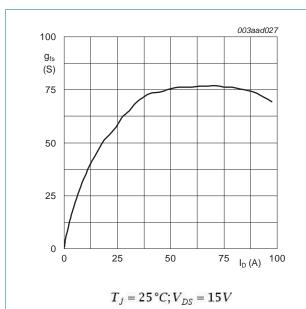


Fig 7. Forward transconductance as a function of drain current; typical values

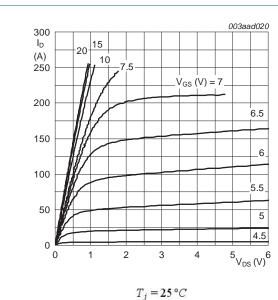
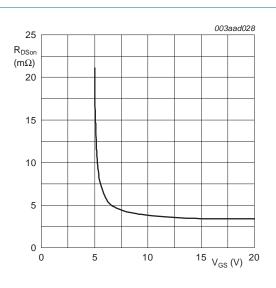
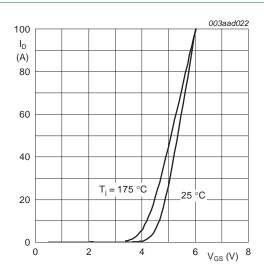


Fig 9. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25 \,^{\circ}C; I_D = 25A$ 

Fig 8. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $V_{DS} > I_D \times R_{DSon}$ 

Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

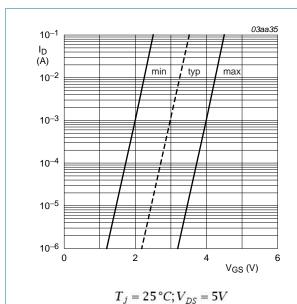


Fig 11. Sub-threshold drain current as a function of gate-source voltage

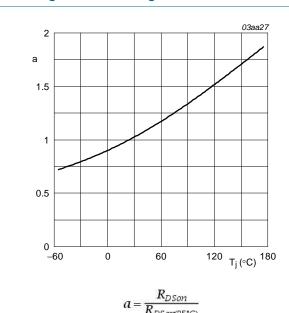


Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature

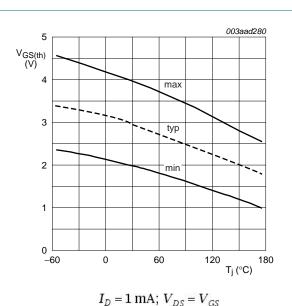


Fig 12. Gate-source threshold voltage as a function of junction temperature

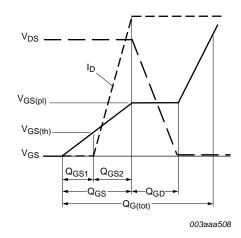


Fig 14. Gate charge waveform definitions

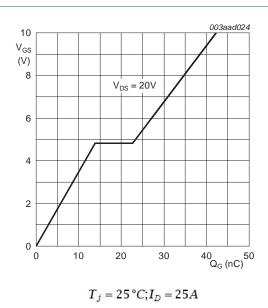
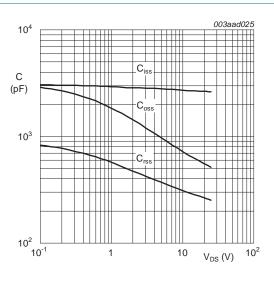


Fig 15. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$ 

Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

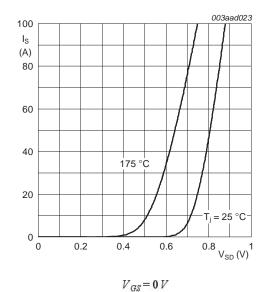


Fig 17. Source current as a function of source-drain voltage; typical values

# 8. Package outline

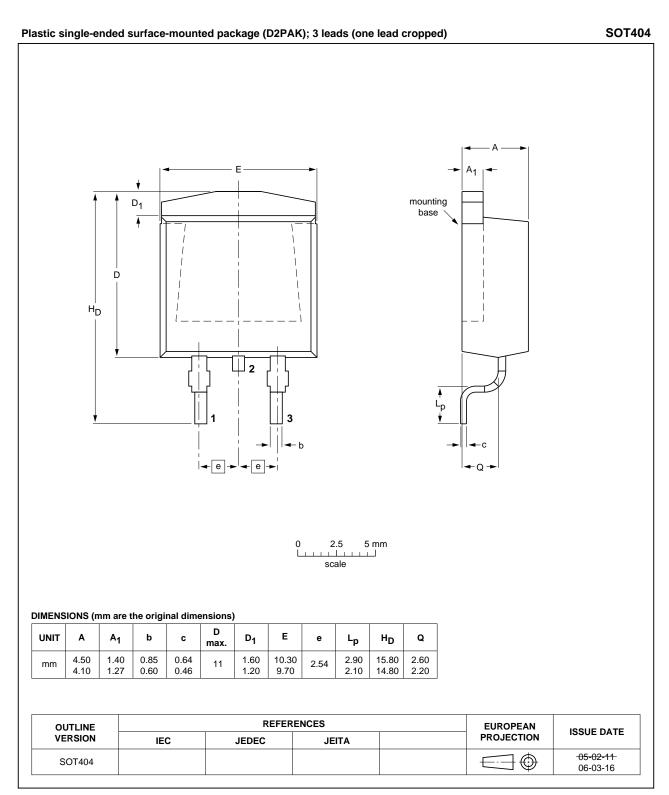


Fig 18. Package outline SOT404 (D2PAK)

# 9. Revision history

# Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN4R5-40BS v.1	20120322	Product data sheet	-	-

# 10. Legal information

#### 10.1 Data sheet status

Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions'
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PSMN4R5-40BS

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# PSMN4R5-40BS

#### N-channel 40 V 4.5 mΩ standard level MOSFET in D2PAK

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## 11. Contact information

For more information, please visit:http://www.nxp.com

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